


<b>Search Notes</b>  	<b>Application/Control No.</b>  10550369	<b>Applicant(s)/Patent Under Reexamination</b>  SASABAYASHI, TAKASHI
	<b>Examiner</b>  DZU LUONG	<b>Art Unit</b>  2871

SEARCHED			
Class	Subclass	Date	Examiner
349	129	2/16/08	Dzu Luong
349	117-121	2/17/08	Dzu Luong

SEARCH NOTES		
Search Notes	Date	Examiner
Search strings: 349/129.ccls. and (stripe same (bend\$3 curv\$3)), 349/129.ccls. and (stripe)	2/16/08	Dzu Luong
Assignee search: fujitsu.as. AND (polymeriz\$4)	2/16/08	Dzu Luong
Search strings: (polymeriz\$4) AND (irradiat\$4 NEAR tilt\$4), (liquid adj crystal LC) NEAR (negative adj dielectric adj constant adj anisotropy)	2/17/08	Dzu Luong

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner